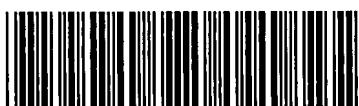


<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10673267	PERETS ET AL.
	<b>Examiner</b> Lee, Siu M	<b>Art Unit</b> 2611

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
375	262, 316, 341, 349	12/18/2006	Siu M. Lee
455	571, 343, 127, 419, 67.3, 263, 312, 337		

<b>SEARCH NOTES</b>			
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>	
US-PGPUB	12/18/2006	Siu M. Lee	
USPAT	12/18/2006	Siu M. Lee	
USOCR	12/18/2006	Siu M. Lee	
EPO	12/18/2006	Siu M. Lee	
JPO	12/18/2006	Siu M. Lee	
DERWENT	12/18/2006	Siu M. Lee	
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EAST	5/30/2007	Siu M. Lee	
Discuss teh amendment with Chieh Fan	5/30/2007	Siu M. Lee	

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>